

Notice of References Cited	Application/Control No. 09/486,480	Applicant(s)/Patent Under Reexam Spudich et al.	
	Examiner S. Devi, Ph.D.	Art Unit 1645	Page 1 of 1

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	Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
A	US 4,338,094	07/06/82	Elahi	23	230
B	US 5,230,998	07/27/93	Neurath et al.	435	7.1
C	US 5,561,045	10/01/96	Dorval et al.	435	5
D	US 6,379,903	04/30/02	Brizzard et al.	435	7.1
E	US 4,029,756	06/14/77	Gaafar	424	1
F	US 4,614,714	09/30/86	Kusakabe et al.	435	25
G	US 5,177,005	01/05/93	Lloyd et al.	435	94
H	US 5,874,668	2/23/99	Xu et al.	73	105
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K	US 6,107,060	08/22/00	Keeling	435	69.7
L	US 5,993,769	11/30/99	Pinnavaia et al.	423	331
M	US 4,629,713	12/16/86	Suzuki et al.	502	84

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N	JP 356152741A	11/26/81	Japan	Sugimori et al.	----	----
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Q						
R						
S						
T						

NON-PATENT DOCUMENTS

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	Koennecke et al. Monatsh. Chem. 113: 331-337, 1982
V	
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X	

* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

² Classifications may be U.S. or foreign.

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